



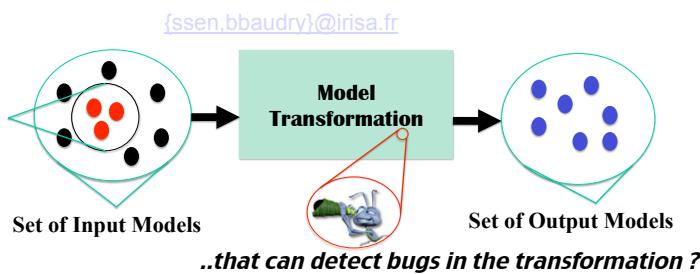
# CARTIER : A TOOL FOR AUTOMATIC TEST MODEL SYNTHESIS

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## The Problem

**What are the test models ...**



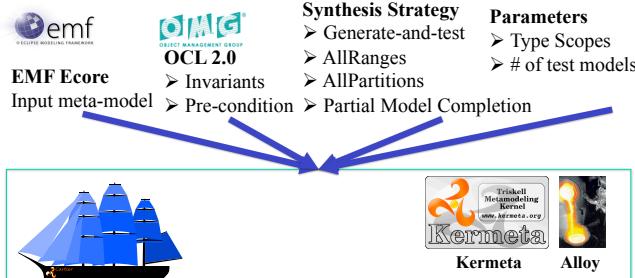
## The Challenges

- ◆ Test models are inter-connected graph of objects
- ◆ Test models must conform to heterogeneous sources of knowledge
- ◆ Manual specification is tedious or impossible due to complexity of creating a large number of conforming test models

## The Solution

**Cartier: A systematic methodology and tool to automatically synthesize test models**

### Cartier Architecture

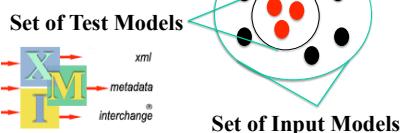


### Cartier Transformation

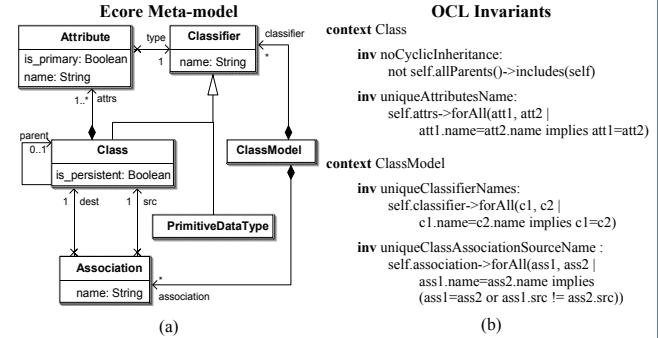
- ① EMF input meta-model to Alloy Signatures and Facts
- ② OCL Invariants to Alloy Facts (Automation is future work)
- ③ Testing strategy to Alloy Predicates and Run Commands

### Cartier Test Model Generation

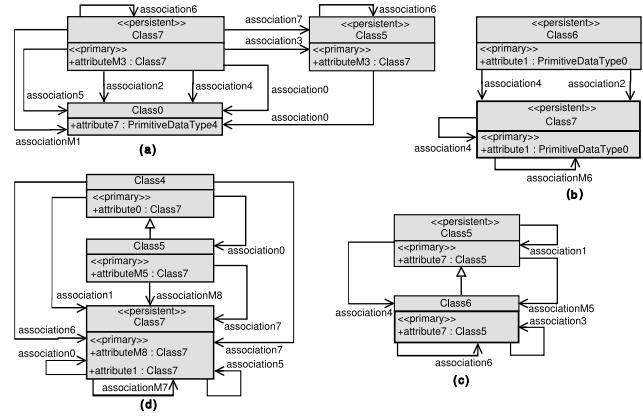
- ① Invoking KodKod to transform Alloy model to Boolean CNF formulae
- ② Invoking SAT Solver for # of solutions
- ③ Alloy Instances to XMI solutions conforming to input meta-model.



### Representative Case Study



### Input meta-model for Simple UML Class Models to RDBMS Models



Some generated UML class models...

## Conclusion

- Cartier generates small models that can detect bugs as shown in the representative case study
- We demonstrate how knowledge from different sources can be combined in Cartier using extensibility features of Kermeta
- We conform to major standardization efforts such as EMF, XMI, and OCL

## References

- [1] Sen, S.; Baudry, B. & Mottu, J. On Combining Multi-formalism Knowledge to Select Test Models for Model Transformation Testing, *IEEE International Conference on Software Testing*, 2008
- [2] Sen, S.; Baudry, B. & Mottu, J. Automatic Test Model Generation Strategies for Model Transformation Testing, *IEEE International Conference on Model Transformation*, 2009
- [3] Bezivin, J.; Rumpe, B.; Schurr, A. & Tratt, L. Model Transformations in Practice Workshop, October 3rd 2005, part of MoDELS 2005, *Proceedings of MoDELS*, 2005

**Download:** <http://www.irisa.fr/triskell/Softwares/protos/Cartier>